


<b>Search Notes</b> 	<b>Application/Control No.</b> 10522774	<b>Applicant(s)/Patent Under Reexamination</b> KAMIKAWA ET AL.
	<b>Examiner</b> TU M NGUYEN	<b>Art Unit</b> 3748

SEARCHED			
Class	Subclass	Date	Examiner
60	274, 285, 286, 295, 297, 300, 303	9/2008	TMN
422	169, 177, 180, 183	9/2008	TMN

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search	9/2008	TMN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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